

TLE6251DS

High Speed CAN-Transceiver with Bus wake-up

Automotive Power



Never stop thinking

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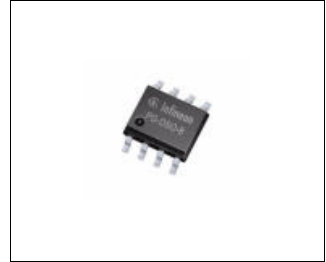
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Features

- CAN data transmission rate up to 1 Mbaud
- Compatible to ISO/DIS 11898
- Supports 12 V and 24 V automotive applications
- Low power mode with remote wake-up via CAN bus
- Wake signaling by RxD change
- No BUS load in stand-by mode
- Wide common mode range for electromagnetic immunity (EMI)
- Digital inputs compatible to 3.3 and 5 V logic devices
- CAN short circuit proof to ground, battery and V_{CC}
- Split termination to stabilize the recessive level
- TxD time-out function
- Overtemperature protection
- Protected against automotive transients
- Green Product (RoHS compliant)
- AEC Qualified



Description

The CAN-transceiver TLE6251DS is a monolithic integrated circuit in a PG-DSO-8 package for high speed differential mode data transmission (up to 1 Mbaud) and reception in automotive and industrial applications. It works as an interface between the CAN protocol controller and the physical bus lines compatible to ISO/DIS 11898.

As a successor to the first generation of HS CAN (TLE6250), the TLE6251DS is designed to provide an excellent passive behavior when the transceiver is switched off (mixed networks, terminal 15/30 applications) and a remote wake-up capability via CAN bus in low power mode. This supports networks with partially un-powered nodes.

The TLE6251DS has two operation modes, the normal and the stand-by mode. These modes can be chosen by the STB pin. If the TLE6251DS is in stand-by mode and a message on the bus is

Type	Package
TLE6251DS	PG-DSO-8

detected, the TLE6251DS changes the level at the RxD pin corresponding to the bus signal (wake-up flag).

The TLE6251DS is also designed to withstand the severe conditions of automotive applications and to support 12 V and 24 V applications.

The IC is based on the Smart Power Technology SPT® which allows bipolar and CMOS control circuitry in accordance with DMOS power devices existing on the same monolithic circuit.

Pin Configuration and Definitions

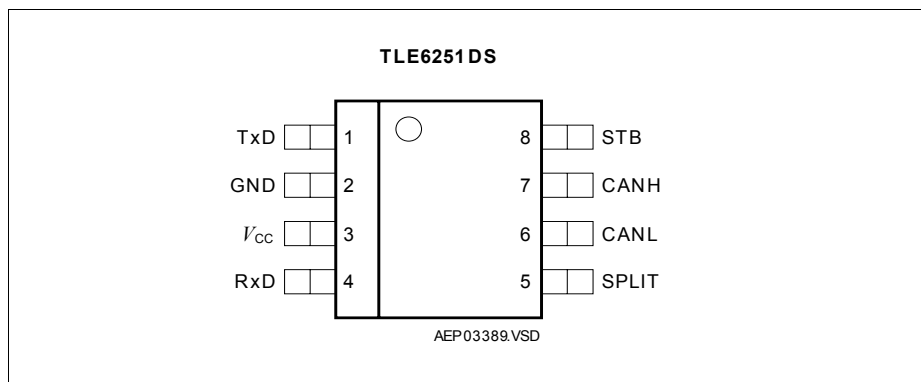


Figure 1 Pin Configuration (top view)

Table 1 Pin Definitions and Functions

Pin No.	Symbol	Function
1	TxD	CAN transmit data input ; 20 kΩ pull-up, LOW in dominant state
2	GND	Ground
3	V _{CC}	5 V supply input ; block to GND with 100 nF ceramic capacitor
4	RxD	CAN receive data output ; LOW in dominant state
5	SPLIT	Split termination output ; to support the recessive voltage level of the bus lines
6	CANL	Low line input ; LOW in dominant state
7	CANH	High line output ; HIGH in dominant state
8	STB	Mode control input ; internal pull-up, see Figure 3

Functional Block Diagram

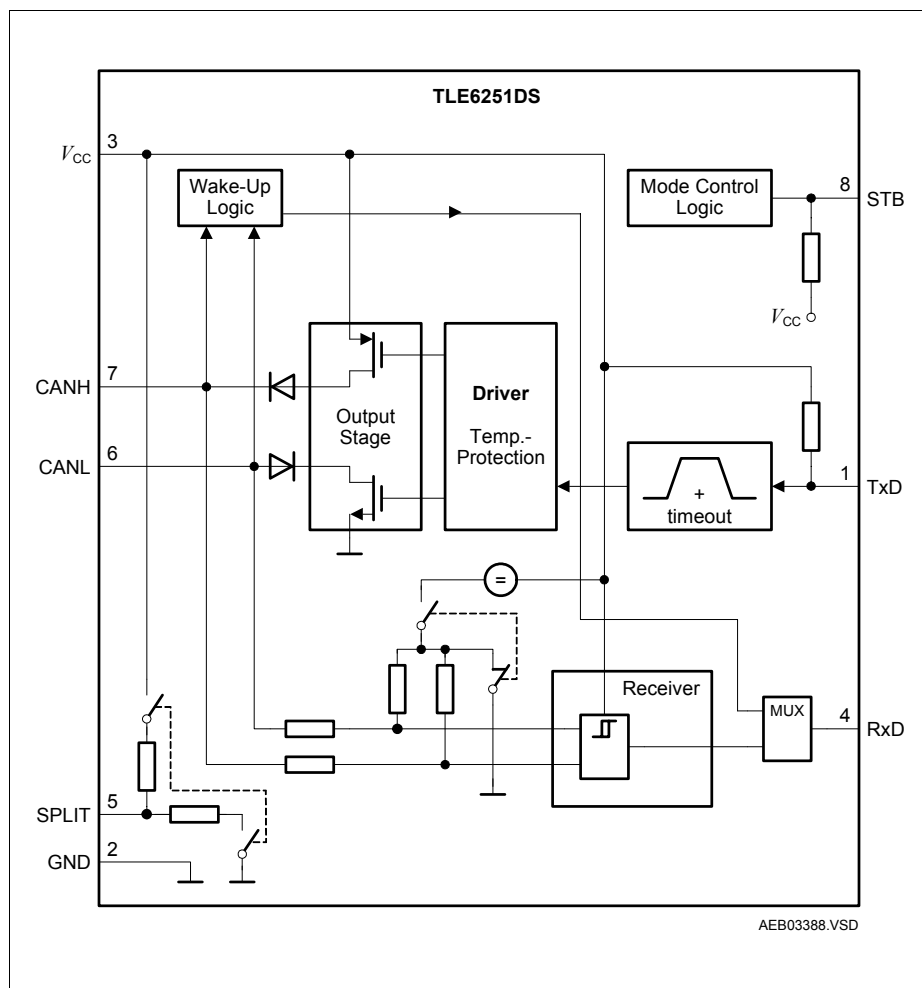


Figure 2 Functional Block Diagram

Application Information

The TLE6251DS has two operation modes, the normal and the standby mode. These modes can be controlled with the STB pin (see [Figure 3](#), [Table 2](#)). The STB pin has an implemented pull-up, so if there is no signal applied to STB or STB = HIGH, the standby mode is activated. To transfer the TLE6251DS into the normal mode, STB has to be switched to LOW.

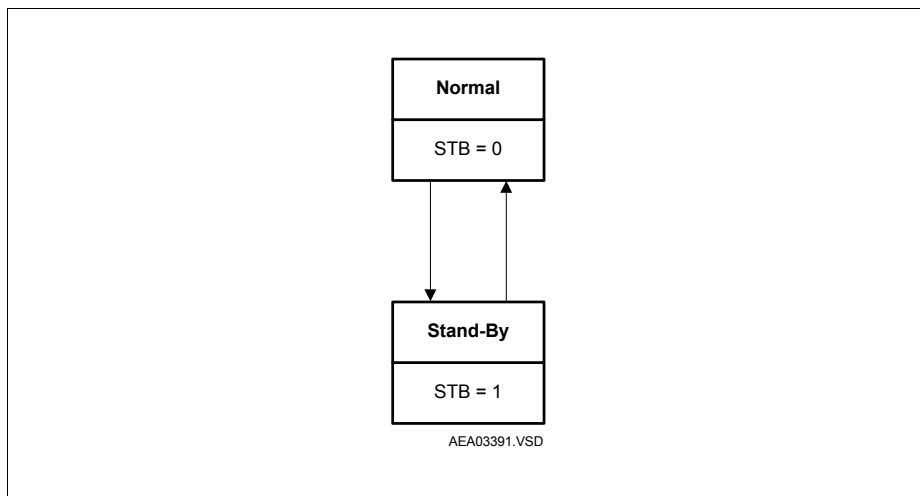


Figure 3 Mode State Diagram

Table 2 Truth Table

Mode	STB	Event	RxD	BUS Termination
Normal	low	bus dominant	low	$V_{CC}/2$
		bus recessive	high	
Stand by	high	wake-up via CAN bus detected	low/high ¹⁾	GND
		no wake-up detected	high	

¹⁾ Signal at RxD changes corresponding to the bus signal during stand by mode. See [Figure 6](#)

Normal Mode

This mode is designed for the normal data transmission/reception within the HS-CAN network.

Transmission

The signal from the μC is applied to the TxD input of the TLE6251DS. Now the bus driver switches the CANH/L output stages to transfer this input signal to the CAN bus lines.

TxD Time-out Feature

If the TxD signal is dominant for a time $t > t_{\text{TxD}}$ the TxD time-out function deactivates the transmission of the signal at the bus. This is realized to prevent the bus from being blocked permanently dominant due to an error.

The transmission is released again, after a rising edge at TxD has been detected.

Reduced Electromagnetic Emission

The bus driver has an implemented control to reduce the electromagnetic emission (EME). This is achieved by controlling the symmetry of the slope, resp. of CANH and CANL.

Overtemperature

The driver stages are protected against overtemperature. Exceeding the shutdown temperature results in deactivation of the driving stages at CANH/L. To avoid a bit failure after cooling down, the signals can be transmitted again only after a dominant to recessive edge at TxD.

Figure 4 shows the way how the transmission stage is deactivated and activated again. First an over temperature condition causes the transmission stage to deactivate. After the over temperature condition is no longer present, the transmission is only possible after the TxD signal has changed to recessive level.

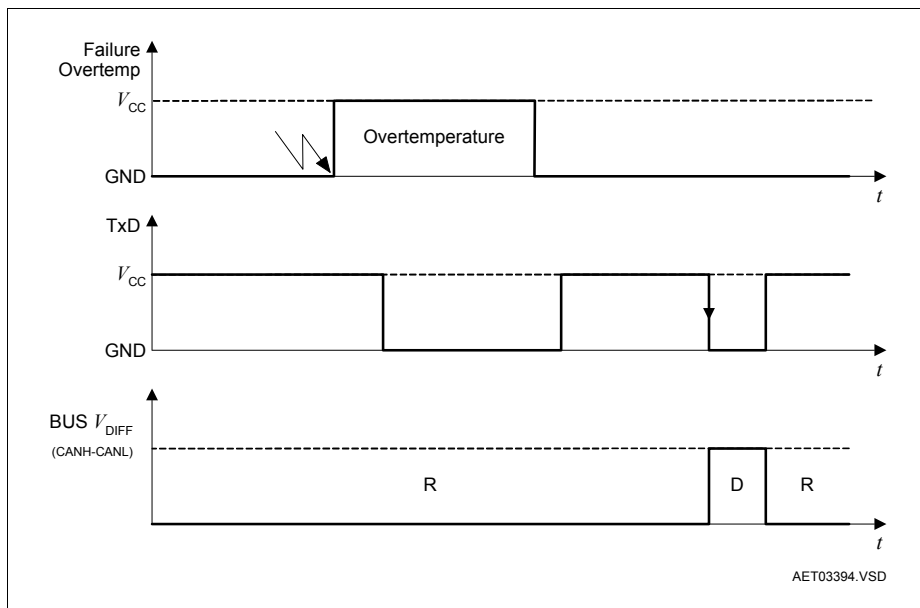


Figure 4 Release of the Transmission after Overtemperature

Reception

The analog CAN bus signals are converted into a digital signal at RxD via the differential input receiver. The RxD signal is switched to RxD output pin via the multiplexer (MUX), see [Figure 2](#). In normal mode the split pin is used to stabilize the recessive common mode signal.

Standby Mode

The standby mode is designed to switch the TLE6251DS into a low power mode with minimum current consumption. The driving stages and the receiver are deactivated. Only the relevant circuitry to guarantee a correct handling of the CAN bus wake-up is still active. This wake-up receiver is also designed to show an excellent immunity against electromagnetic noise (EMI).

Change into Standby Mode during CAN Bus Failure

It is possible to change from normal mode into the standby mode if the bus is dominant due to a bus failure without setting the RxD wake flag to LOW. The advantage is, that the TLE6251DS can be kept in the standby mode even if a bus failure occurs.

[Figure 5](#) shows this mechanism in detail. During a bus network failure, the bus might be dominant. Normal communication is not possible until the failure is removed. To reduce the current consumption, it makes sense to switch over to standby mode. This is possible with the

TLE6251DS. If the dominant signal switches back to recessive level, e.g. failure removed, a wake-up via CAN bus (recessive to dominant signal detected) is possible.

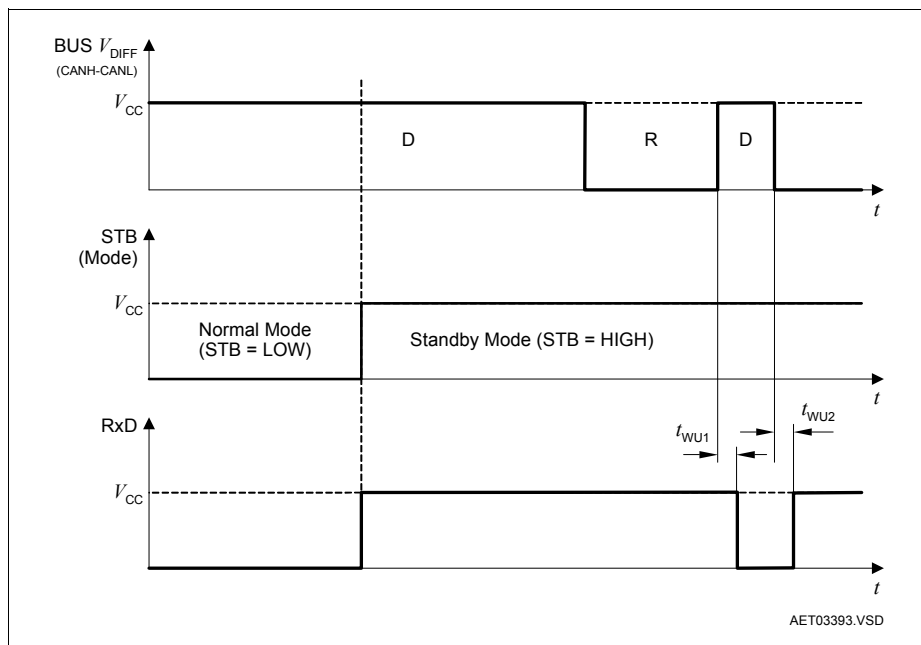


Figure 5 Go-To Standby Mode during Bus Dominant Condition

Wake-up via CAN Message

During standby mode, a dominant CAN message on the bus longer than the filtering time $t > t_{WU1}$, leads to the activation of the wake-up. The wake-up during standby mode is signaled with the RxD output pin. A dominant signal longer $t > t_{WU1}$ on the CAN bus switches the RxD level to LOW, with a following recessive signal on the CAN bus longer $t > t_{WU2}$ the RxD level is switched to high, see [Figure 6](#).

The μC is able to detect this change at RxD and switch the transceiver into the normal mode.

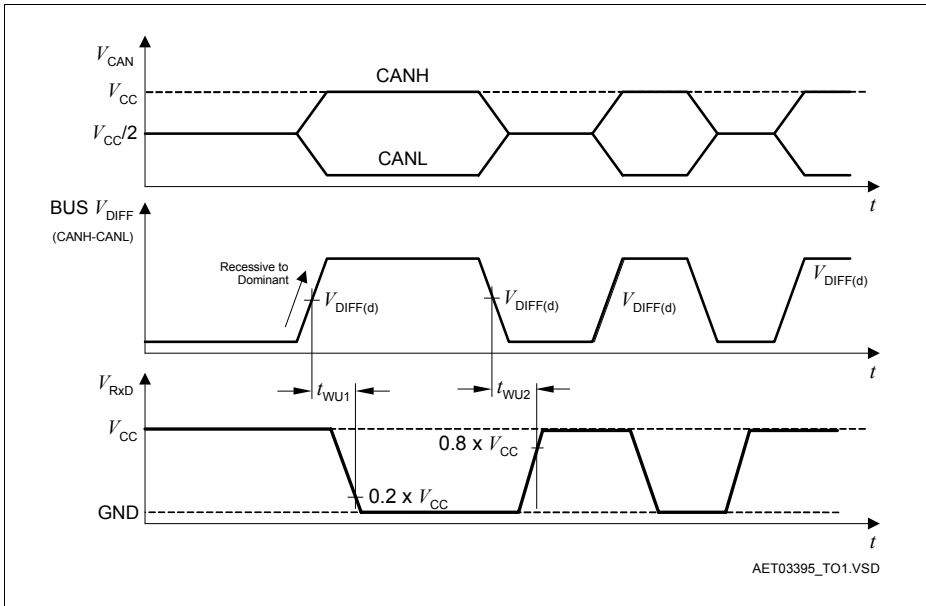


Figure 6 Wake-up behavior

Split Circuit

The split circuitry is activated during normal mode and deactivated (SPLIT pin floating) during standby mode. The SPLIT pin is used to stabilize the recessive common mode signal in normal mode. This is realized with a stabilized voltage of $0.5 V_{CC}$ at SPLIT.

A correct application of the SPLIT pin is shown in [Figure 7](#). The split termination for the left and right node is realized with two 60Ω resistances and one 10 nF capacitor. The center node in this example is a stub node and the recommended value for the split resistances is $1.5 \text{ k}\Omega$.

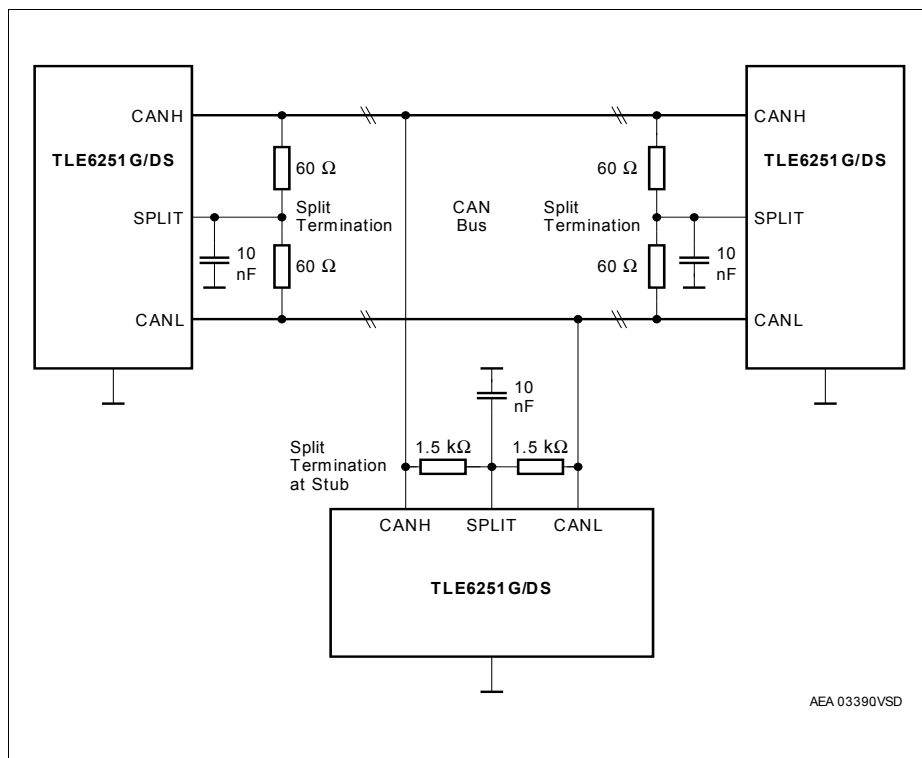


Figure 7 Application of the SPLIT Pin for Normal Nodes and one Stub Node

Other Features

Fail Safe

If the device is supplied but there is no signal at the digital inputs, the TxD and STB have an internal pull-up path, to prevent the transceiver to switch into the normal mode or send a dominant signal on the bus.

Un-supplied Node

The CANH/CANL pins remain high ohmic, if the transceiver is un-supplied.

Table 3 Absolute Maximum Ratings

Parameter	Symbol	Limit Values		Unit	Remarks
		Min.	Max.		
Voltages					
Supply voltage	V_{CC}	-0.3	5.5	V	–
CAN bus voltage (CANH, CANL)	$V_{CANH/L}$	-32	40	V	–
CAN bus differential voltage CANH, CANL, SPLIT	$V_{CAN\ diff}$	-40	40	V	CANH - CANL < 40 V CANH - SPLIT < 40 V CANL - SPLIT < 40 V
Input voltage at SPLIT	V_{SPLIT}	-27	40	V	–
Logic voltages at STB, TxD, RxD	V_I	-0.3	V_{CC}	V	0 V < V_{CC} < 5.5 V
Electrostatic discharge voltage at CANH, CANL, SPLIT vs. GND	V_{ESD}	-6	6	kV	human body model (100 pF via 1.5 kΩ)
Electrostatic discharge voltage	V_{ESD}	-2	2	kV	human body model (100 pF via 1.5 kΩ)
Temperatures					
Storage temperature	T_i	-40	150	°C	–

Note: Maximum ratings are absolute ratings; exceeding any one of these values may cause irreversible damage to the integrated circuit.

Table 4 Operating Range

Parameter	Symbol	Limit Values		Unit	Remarks
		Min.	Max.		
Supply voltage	V_{CC}	4.75	5.25	V	—
Junction temperature	T_j	-40	150	°C	—

Thermal Resistances

Junction ambient	R_{thj-a}	—	185	K/W	¹⁾
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Thermal Shutdown (junction temperature)

Thermal shutdown temperature	T_{jsD}	150	190	°C	—
Thermal shutdown hyst.	ΔT	—	10	K	—

¹⁾ Calculation of the junction temperature $T_j = T_{amb} + P \times R_{thj-a}$

Table 5 Electrical Characteristics

4.75 V < V_{CC} < 5.25 V; $R_L = 60\ \Omega$; $-40\ ^\circ\text{C} < T_j < 150\ ^\circ\text{C}$; all voltages with respect to ground; positive current flowing into pin; unless otherwise specified.

Parameter	Symbol	Limit Values			Unit	Remarks
		Min.	Typ.	Max.		

Current Consumption

Current consumption	I_{CC}	–	6	10	mA	recessive state; $V_{\text{TxD}} = V_{CC}$
Current consumption	I_{CC}	–	45	70	mA	dominant state; $V_{\text{TxD}} = 0\ \text{V}$
Current consumption	$I_{CC,\text{stb}}$	–	20	30	μA	stand-by mode; TxD = high

Receiver Output RxD

HIGH level output current	$I_{\text{RD,H}}$	–	-4	-2	mA	$V_{\text{RD}} = 0.8 \times V_{CC}$
		–	-100	–	μA	stand-by mode
LOW level output current	$I_{\text{RD,L}}$	2	4	–	mA	$V_{\text{RD}} = 0.2 \times V_{CC}$
Short circuit current	$I_{\text{SC,RxD}}$	–	15	20	mA	–

Transmission Input TxD

HIGH level input voltage threshold	$V_{\text{TD,H}}$	2.0	–	–	V	recessive state
LOW level input voltage threshold	$V_{\text{TD,L}}$	–	–	0.8	V	dominant state
TxD pull-up resistance	R_{TD}	10	20	40	k Ω	–
TxD input hysteresis	$V_{\text{TD hys}}$	–	200	–	mV	–

Stand By Input (pin STB)

HIGH level input voltage threshold	$V_{\text{STB,H}}$	2.0	–	–	V	normal mode
LOW level input voltage threshold	$V_{\text{STB,L}}$	–	–	0.8	V	receive-only mode
STB pull-up resistance	R_{STB}	10	20	40	k Ω	–
STB input hysteresis	$V_{\text{STB hys}}$	–	200	–	mV	–

Table 5 Electrical Characteristics (cont'd)

4.75 V < V_{CC} < 5.25 V; $R_L = 60 \Omega$; $-40^\circ\text{C} < T_j < 150^\circ\text{C}$; all voltages with respect to ground; positive current flowing into pin; unless otherwise specified.

Parameter	Symbol	Limit Values			Unit	Remarks
		Min.	Typ.	Max.		
Split Termination Output (pin SPLIT)						
Split output voltage	V_{SPLIT}	$0.3 \times V_{\text{CC}}$	$0.5 \times V_{\text{CC}}$	$0.7 \times V_{\text{CC}}$	V	normal mode; $-500 \mu\text{A} < I_{\text{SPLIT}} < 500 \mu\text{A}$
	V_{SPLIT}	$0.45 \times V_{\text{CC}}$	$0.5 \times V_{\text{CC}}$	$0.55 \times V_{\text{CC}}$	V	normal mode; no Load
Leakage current	I_{SPLIT}	-5	0	5	μA	standby mode; $-22 \text{ V} < V_{\text{SPLIT}} < 35 \text{ V}$
SPLIT output resistance	R_{SPLIT}	—	600	—	Ω	—

Bus Receiver

Differential receiver threshold voltage, normal mode	$V_{\text{diff,rdN}}$	—	0.8	0.9	V	recessive to dominant
	$V_{\text{diff,drN}}$	0.5	0.6	—	V	dominant to recessive
Differential receiver threshold, low power mode	$V_{\text{diff,rdLP}}$		0.9	1.15	V	recessive to dominant
	$V_{\text{diff,drLP}}$	0.4	0.8		V	dominant to recessive
Common Mode Range	CMR	-12	—	12	V	$V_{CC} = 5 \text{ V}$
Differential receiver hysteresis	$V_{\text{diff,hys}}$	—	200	—	mV	—
CANH, CANL input resistance	R_i	10	20	30	k Ω	recessive state
Differential input resistance	R_{diff}	20	40	60	k Ω	recessive state

Bus Transmitter

CANL/CANH recessive output voltage	$V_{\text{CANL/H}}$	2.0	2.5	3.0	V	$V_{\text{TXD}} = V_{CC}$; no load
CANH, CANL recessive output voltage difference	V_{diff}	-500	—	50	mV	$V_{\text{TXD}} = V_{CC}$; no load
CANL dominant output voltage	V_{CANL}	0.5	—	2.25	V	$V_{\text{TXD}} = 0 \text{ V}$; $V_{CC} = 5 \text{ V}$
CANH dominant output voltage	V_{CANH}	2.75	—	4.5	V	$V_{\text{TXD}} = 0 \text{ V}$; $V_{CC} = 5 \text{ V}$

Table 5 Electrical Characteristics (cont'd)

4.75 V < V_{CC} < 5.25 V; $R_L = 60 \Omega$; $-40^\circ\text{C} < T_j < 150^\circ\text{C}$; all voltages with respect to ground; positive current flowing into pin; unless otherwise specified.

Parameter	Symbol	Limit Values			Unit	Remarks
		Min.	Typ.	Max.		
CANH, CANL dominant output voltage difference $V_{\text{diff}} = V_{\text{CANH}} - V_{\text{CANL}}$	V_{diff}	1.5	—	3.0	V	$V_{\text{TxD}} = 0 \text{ V}$; $V_{CC} = 5 \text{ V}$
CANL short circuit current	I_{CANLsc}	50	80	200	mA	$V_{\text{CANLshort}} = 18 \text{ V}$
CANH short circuit current	I_{CANHsc}	-200	-80	-50	mA	$V_{\text{CANHshort}} = 0 \text{ V}$
Leakage current	$I_{\text{CANH,L,lk}}$	-	-	-5	μA	$V_{CC} = 0 \text{ V}$; $0 \text{ V} < V_{\text{CANH,L}} < 5 \text{ V}$

Dynamic CAN-Transceiver Characteristics

Propagation delay TxD-to-RxD LOW (recessive to dominant)	$t_{\text{d(L),TR}}$	—	150	255	ns	$C_L = 47 \text{ pF}$; $R_L = 60 \Omega$; $V_{CC} = 5 \text{ V}$; $C_{\text{RxD}} = 15 \text{ pF}$
Propagation delay TxD-to-RxD HIGH (dominant to recessive)	$t_{\text{d(H),TR}}$	—	150	255	ns	$C_L = 47 \text{ pF}$; $R_L = 60 \Omega$; $V_{CC} = 5 \text{ V}$; $C_{\text{RxD}} = 15 \text{ pF}$
Propagation delay TxD LOW to bus dominant	$t_{\text{d(L),T}}$	—	50	120	ns	$C_L = 47 \text{ pF}$; $R_L = 60 \Omega$; $V_{CC} = 5 \text{ V}$
Propagation delay TxD HIGH to bus recessive	$t_{\text{d(H),T}}$	—	50	120	ns	$C_L = 47 \text{ pF}$; $R_L = 60 \Omega$; $V_{CC} = 5 \text{ V}$
Propagation delay bus dominant to RxD LOW	$t_{\text{d(L),R}}$	—	100	135	ns	$C_L = 47 \text{ pF}$; $R_L = 60 \Omega$; $V_{CC} = 5 \text{ V}$; $C_{\text{RxD}} = 15 \text{ pF}$
Propagation delay bus recessive to RxD HIGH	$t_{\text{d(H),R}}$	—	100	135	ns	$C_L = 47 \text{ pF}$; $R_L = 60 \Omega$; $V_{CC} = 5 \text{ V}$; $C_{\text{RxD}} = 15 \text{ pF}$
Min. dominant time for bus wake-up signal (RxD high to low)	t_{WU1}	0.75	3	5	μs	$t_{\text{WU1}} = t_{\text{d(L),R}} + t_{\text{WU}}$ see Figure 6

Table 5 Electrical Characteristics (cont'd)

4.75 V < V_{CC} < 5.25 V; $R_L = 60\ \Omega$; $-40\ ^\circ\text{C} < T_j < 150\ ^\circ\text{C}$; all voltages with respect to ground; positive current flowing into pin; unless otherwise specified.

Parameter	Symbol	Limit Values			Unit	Remarks
		Min.	Typ.	Max.		
Min. recessive time for bus wake-up signal (RxD low to high)	t_{WU2}	0.75	3	5	μs	$t_{WU2} = t_{d(H),R} + t_{WU}$ see Figure 6
TxD permanent dominant disable time	t_{TxD}	0.3	—	1.0	ms	—

Diagrams

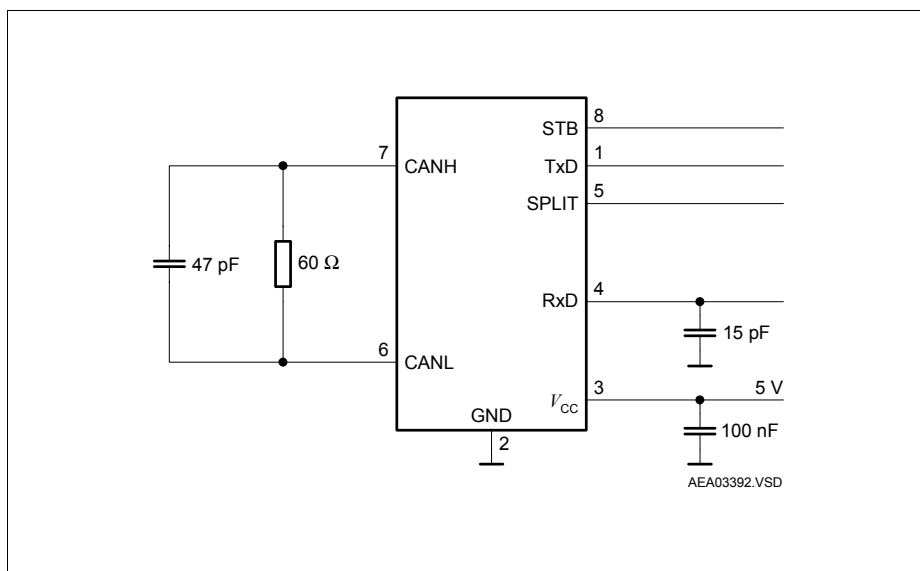


Figure 8 Test Circuits for Dynamic Characteristics

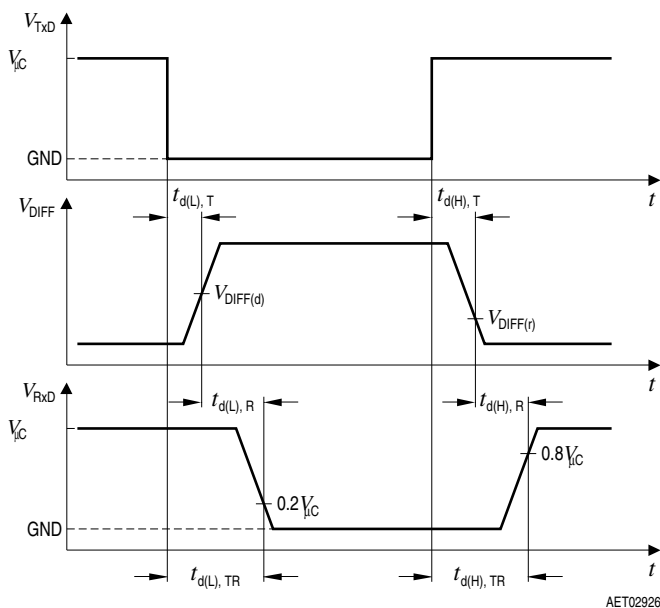


Figure 9 Timing Diagrams for Dynamic Characteristics

Application

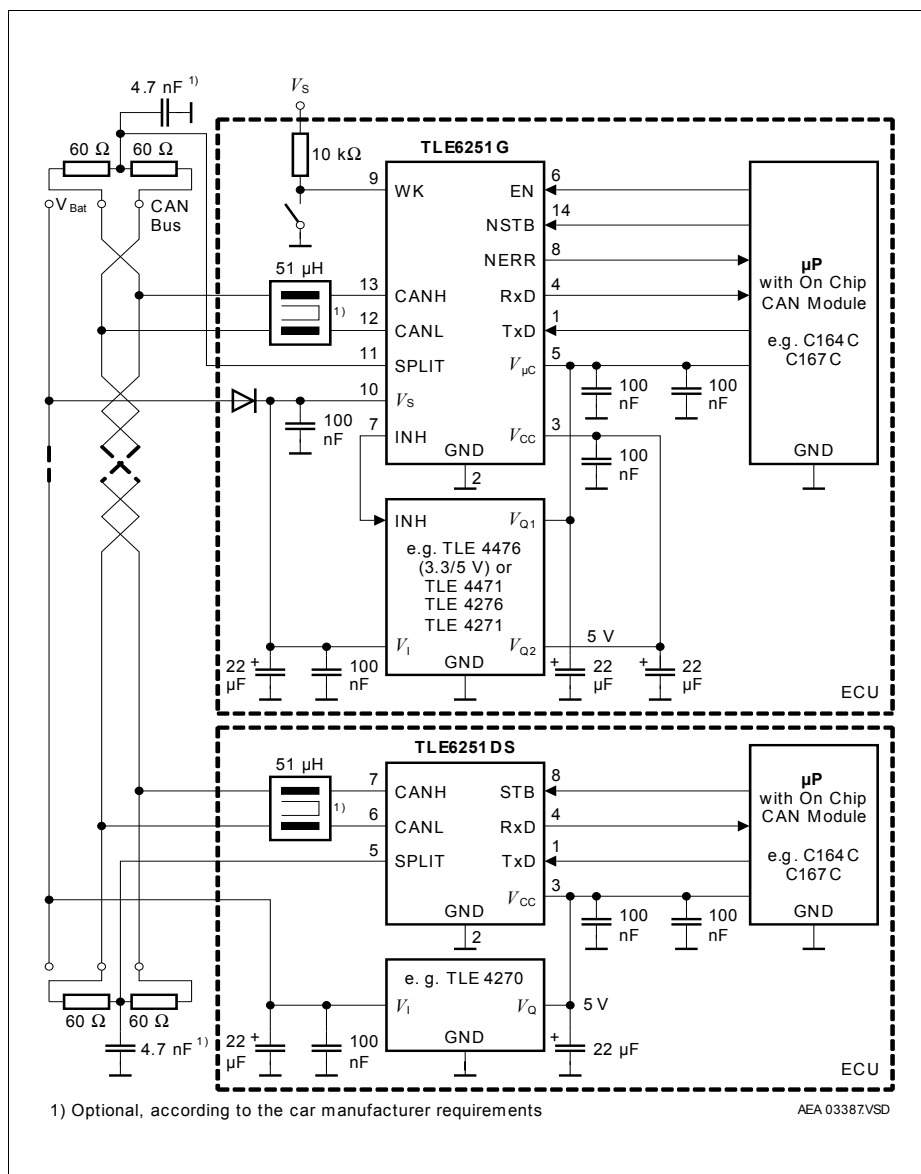


Figure 10 Application Circuit

Package Outlines

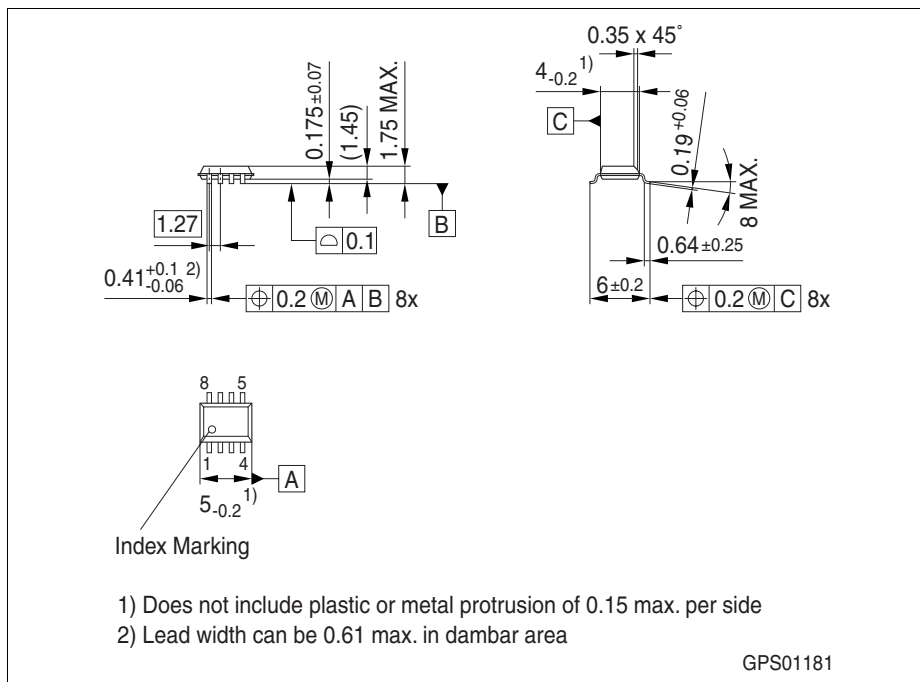


Figure 11 **PG-DSO-8** (PG-DSO-8-16 Plastic Dual Small Outline)

Green Product (RoHS compliant)

To meet the world-wide customer requirements for environmentally friendly products and to be compliant with government regulations the device is available as a green product. Green products are RoHS-Compliant (i.e Pb-free finish on leads and suitable for Pb-free soldering according to IPC/JEDEC J-STD-020).

You can find all of our packages, sorts of packing and others in our Infineon Internet Page “Products”: <http://www.infineon.com/products>.

SMD = Surface Mounted Device

Dimensions in mm

Revision History

Version	Date	Changes
Rev. 3.1	2007-08-20	RoHS-compliant version of the TLE6251DS • All pages: Infineon logo updated • Page 3: “added AEC qualified” and “RoHS” logo, “Green Product (RoHS compliant)” and “AEC qualified” statement added to feature list, package name changed to RoHS compliant versions, package picture updated, ordering code removed • Page 21: - Change package drawing to GPS01181 - Package name changed to RoHS compliant versions, “Green Product” description added • added Revision History • updated Legal Disclaimer

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